

Notice of References Cited	Application/Control No. 10/509,393	Applicant(s)/Patent Under Reexamination STUDER, CHRISTOPH	
	Examiner Jinhee J. Lee	Art Unit 2831	Page 1 of 1

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-3,772,454	11-1973	Donecker et al.	174/113R
	B	US-			
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	F	US-			
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	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	EP 577233 A1	01-1994	European Patent	HUETTNER, PETER DIPL-ING	H01B 07/28
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NON-PATENT DOCUMENTS

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	U	English Abstract for EP 577233 A1□□
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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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